

DESCRIPTION

The ICPL0600, ICPL0601 and ICPL0611 devices each consist of an infrared emitting diode, optically coupled to a high speed integrated photo detector logic gate with a strobable output.

These devices belong to Isocom Compact Range of Optocouplers.

FEATURES

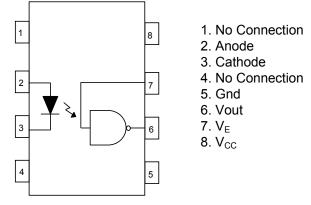
- Half Pitch 1.27mm
- High Speed 10Mbit/s
- 10kV/µs min. Common Mode Transient Immunity (ICPL0611)
- High AC Isolation voltage 3750V_{RMS}
- Guaranteed Performance from -40°C to 85°C
- Wide Operating Temperature Range -40°C to 100°C
- Logic Gate Output
- Pb Free and RoHS Compliant
- Halogen Free
- Safety Approvals Pending

APPLICATIONS

- Line Receivers, Data Communication
- LSTTL to TTL, LSTTL or 5V CMOS
- Data Multiplexing
- Pulse Transformer Replacement
- Switch Mode Power Supplies
- Ground Loop Elimination
- Computer Peripheral Interface

ORDER INFORMATION

 Add T&R after PN for Surface Mount Tape & Reel



A $0.1\mu F$ bypass capacitor must be connected between pins 8 and 5.

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$)

Input Diode

Forward Current	20mA
Reverse Voltage	5V
Power dissipation	40mW

Output

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Total Package

Isolation Voltage37Operating Temperature-4Storage Temperature-5Lead Soldering Temperature (10s)26

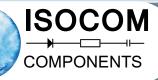
3750V_{RMS} -40 to 100 °C -55 to 125 °C 260°C

ISOCOM COMPONENTS 2004 LTD

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Truth Table (Positive Logic)

Input	Enable	Output
Н	Н	L
L	Н	Н
Н	L	Н
L	L	Н
Н	NC	L
L	NC	Н

ELECTRICAL CHARACTERISTICS (T_A = -40°C to 85°C unless otherwise specified)

INPUT

Parameter	Symbol	Test Condition	Min	Тур.*	Max	Unit
Forward Voltage	$V_{\rm F}$	$I_F = 10 mA$		1.4	1.8	V
Reverse Voltage	V _R	$I_R = 10 \mu A$	5.0			V
Temperature Coefficient of V _F	$\Delta V_F / \Delta T_A$	$I_F = 10 m A$		-1.8		mV/°C
Input Capacitance	C _{IN}	$V_F = 0V, f = 1MHz$		60		pF

OUTPUT

Parameter	Symbol	Test Condition	Min	Тур.*	Мах	Unit
High Level Supply Current	I _{CCH}	$I_F = 0mA, V_E = 0.5V, V_{CC} = 5.5V$			10	mA
Low Level Supply Current	I _{CCL}	$I_F = 10 \text{mA}, V_{CC} = 5.5 \text{V}$			13	mA
High Level Enable Current	$I_{\rm EH}$	$V_E = 2.0V, V_{CC} = 5.5V$			-1.6	mA
Low Level Enable Current	I_{EL}	$V_E = 0.5V, V_{CC} = 5.5V$			-1.6	mA
High Level Enable Voltage	V _{EH}	$I_F = 10 \text{mA}, V_{CC} = 5.5 \text{V}$	2.0			V
Low Level Enable Voltage	V _{EL}	$I_F = 10 \text{mA}, V_{CC} = 5.5 \text{V}$			0.8	V

* Typical values at $T_A = 25^{\circ}C$



ELECTRICAL CHARACTERISTICS (T_A = -40°C to 85°C unless otherwise specified)

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Parameter	Symbol	Test Condition	Min	Тур.*	Max	Unit
High Level Output Current	I _{OH}	$\label{eq:V_CC} \begin{split} V_{CC} &= 5.5 V, V_E = 2.0 V, \\ V_O &= 5.5 V, I_F = 250 \mu A \end{split}$			100	μΑ
Low Level Output Voltage	V _{OL}	$V_{CC} = 5.5V, V_E = 2.0V,$ $I_F = 5mA, I_{OL} = 13mA$			0.6	V
Input Threshold Current	I _{FT}	$V_{CC} = 5.5V, V_E = 2.0V,$ $V_O = 0.6V, I_{OL} = 13mA$			5	mA

Switching Characteristics ($T_A = -40^{\circ}C$ to 85°C, $V_{CC} = 5V$, $I_F = 7.5$ mA unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур.*	Max	Unit
Propagation Delay Time to Output High Level	t _{PHL}	$C_{L} = 15 \text{pF}, R_{L} = 350\Omega,$ $T_{A} = 25^{\circ}\text{C}$		35	75	ns
Propagation Delay Time to Output Low level	t _{PLH}	$C_{L} = 15 \text{pF}, R_{L} = 350\Omega,$ $T_{A} = 25^{\circ}\text{C}$		45	75	ns
Pulse Width Distortion	t _{PHL} -t _{PLH}	$C_L = 15 \text{pF}, R_L = 350\Omega$		10	35	ns
Output Rise Time	t _r	$C_L = 15 \text{pF}, R_L = 350\Omega$		30	40	ns
Output Fall Time	t _f	$C_{\rm L} = 15 \rm pF, R_{\rm L} = 350 \Omega$		10	20	ns
Enable Propagation Delay Time to Output High Level	t _{ELH}	$I_{F} = 7.5 \text{mA}, \\ V_{EL} = 0V, V_{EH} = 3V, \\ C_{L} = 15 \text{pF}, R_{L} = 350 \Omega$		30	40	ns
Enable Propagation Delay Time to Output Low Level	t _{EHL}			20	30	ns

* Typical values at $T_A = 25^{\circ}C$



ELECTRICAL CHARACTERISTICS (T_A = -40°C to 85°C unless otherwise specified)

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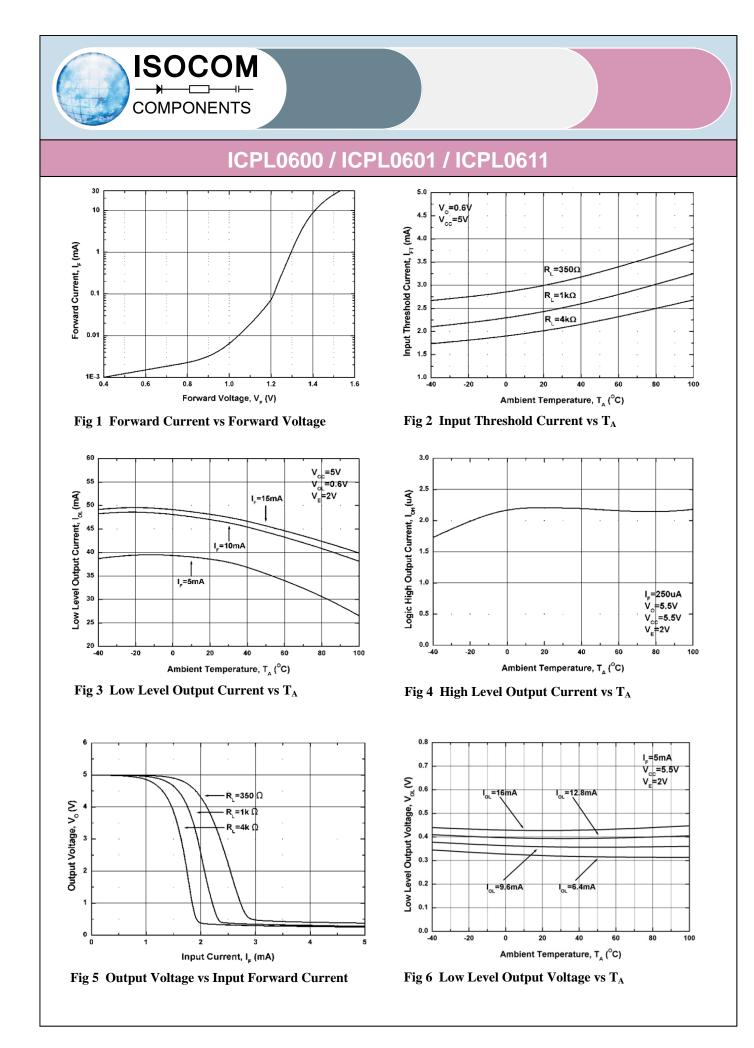
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Switching Characteristics ($T_A = -40^{\circ}C$ to 85°C, $V_{CC} = 5V$, $I_F = 7.5mA$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур.*	Мах	Unit
Common Mode Transient Immunity at	CM _H	ICPL0600 (Fig 14)				V/µs
Logic High		$\begin{split} I_{F} &= 0mA, V_{OH} = 2V, \\ R_{L} &= 350\Omega, V_{CM} = 10Vp\text{-}p, \\ T_{A} &= 25^{\circ}\text{C} \end{split}$				
		ICPL0601 (Fig 14)	5000			1
		$\begin{split} I_{\rm F} &= 0 {\rm mA}, \ V_{\rm OH} = 2 {\rm V}, \\ R_{\rm L} &= 350 \Omega, \ V_{\rm CM} = 50 {\rm Vp}{\rm -p}, \\ T_{\rm A} &= 25^{\circ} {\rm C} \end{split}$				
		ICPL0611 (Fig 14)	10000			
		$I_{F} = 0mA, V_{OH} = 2V, R_{L} = 350\Omega, V_{CM} = 400Vp-p, T_{A} = 25^{\circ}C$				
		ICPL0611 (Fig 15)	15000			1
		$\begin{split} I_{F} &= 0 m A, \ V_{OH} = 2 V, \\ R_{L} &= 350 \Omega, \ V_{CM} = 400 V p \text{-} p, \\ T_{A} &= 25^{\circ} C \end{split}$				
Common Mode	CML	ICPL0600 (Fig 14)				V/µs
Transient Immunity at Logic Low		$I_{\rm F} = 7.5 \text{mA}, V_{\rm OL} = 0.8 \text{V}, \\ R_{\rm L} = 350 \Omega, V_{\rm CM} = 10 \text{Vp-p}, \\ T_{\rm A} = 25^{\circ} \text{C}$				
		ICPL0601 (Fig 14)	5000			1
		$I_{\rm F} = 7.5 \text{mA}, V_{\rm OL} = 0.8 \text{V}, \\ R_{\rm L} = 350 \Omega, V_{\rm CM} = 50 \text{Vp-p}, \\ T_{\rm A} = 25^{\circ} \text{C}$				
		ICPL0611 (Fig 14)	10000			1
		$I_{\rm F} = 7.5 \text{mA}, V_{\rm OL} = 0.8 \text{V}, \\ R_{\rm L} = 350 \Omega, V_{\rm CM} = 400 \text{Vp-p}, \\ T_{\rm A} = 25^{\circ} \text{C}$				
		ICPL0611 (Fig 15)	15000]
		$I_{F} = 7.5 \text{mA}, V_{OL} = 0.8 \text{V}, R_{L} = 350 \Omega, V_{CM} = 400 \text{Vp-p}, T_{A} = 25^{\circ}\text{C}$				

* Typical values at $T_A = 25^{\circ}C$





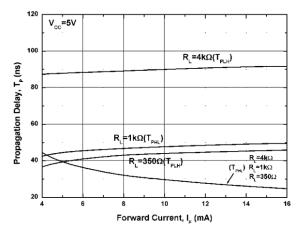


Fig 7 Propagation Delay Time vs Forward Current

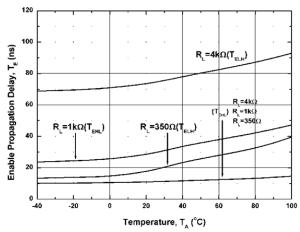
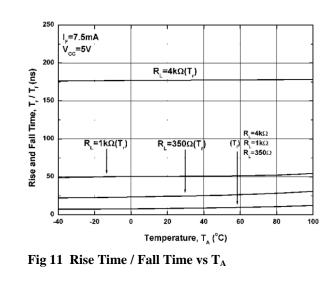


Fig 9 Enable Propagation Delay Time vs T_A



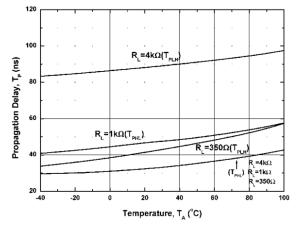


Fig 8 Propagation Delay Time vs T_A

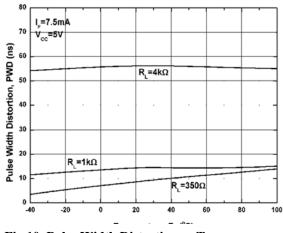
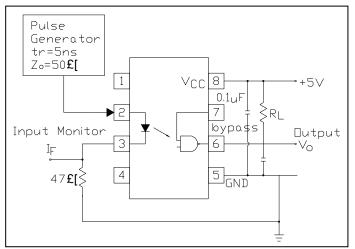


Fig 10 Pulse Width Distortion vs T_A





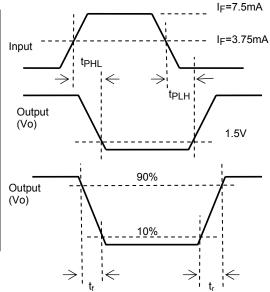


Fig 12 t_{PHL} , t_{PLH} , t_r and t_f Test Circuit

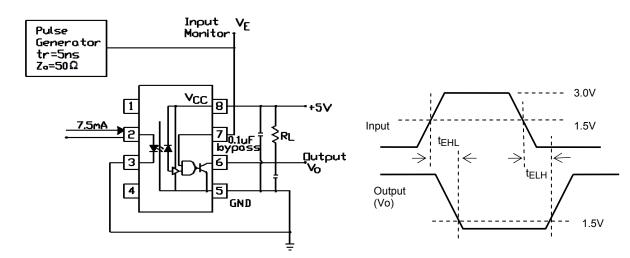
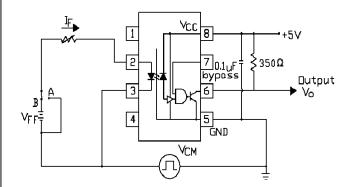


Fig 13 t_{EHL} and t_{ELH} Test Circuit







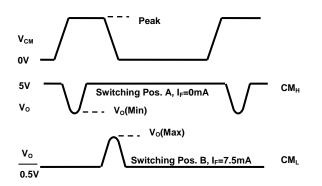


Fig 14 Common Mode Transient Immunity Test Circuit

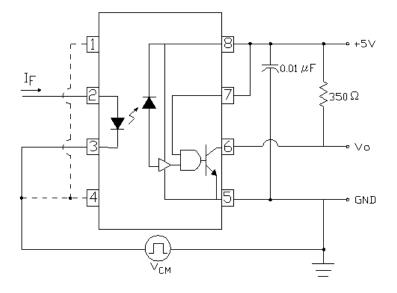


Fig 15 High Common Mode Transient Immunity Test Circuit

Common mode transient immunity in logic high level is the maximum tolerable (positive) dV_{CM}/dt on the leading edge of the common mode pulse signal V_{CM} , to assure that the output will remain in a logic high state (i.e., $V_O > 2.0V$).

Common mode transient immunity in logic low level is the maximum tolerable (negative) dV_{CM}/dt on the trailing edge of the common mode pulse signal, V_{CM} , to assure that the output will remain in a logic low state (i.e., $V_O < 0.8V$).



Notes:

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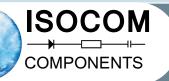
- The V_{CC} supply must be bypassed by a 0.1μ F capacitor or larger with good high frequency characteristic and should be connected as close as possible to the package V_{CC} and GND pins.
- Enable Input No pull up resistor required as the device has an internal pull up resistor.
- t_{PLH} is measured from the 3.75mA level on the HIGH to LOW transition of the input current pulse to the 1.5 V level on the LOW to HIGH transition of the output voltage pulse.
- t_{PHL} is measured from the 3.75mA level on the LOW to HIGH transition of the input current pulse to the 1.5 V level on the HIGH to LOW transition of the output voltage pulse.
- t_r Rise time is measured from the 10% to the 90% levels on the LOW to HIGH transition of the output pulse.
- t_f Fall time is measured from the 90% to the 10% levels on the HIGH to LOW transition of the output pulse.
- t_{ELH} is measured from the 1.5V level on the HIGH to LOW transition of the input Enable voltage pulse to the 1.5V level on the LOW to HIGH transition of the output voltage pulse.
- t_{EHL} is measured from the 1.5V level on the LOW to HIGH transition of the input Enable voltage pulse to the 1.5V level on the HIGH to LOW transition of the output voltage pulse.
- CM_H- The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the HIGH state (i.e., V₀ > 2.0V).
- CM_L The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the LOW output state (i.e., $V_O < 0.8V$).



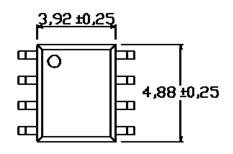
ORDER INFORMATION

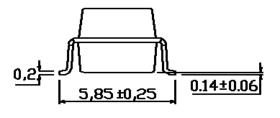
ICPL0600, ICPL0601, ICPL0611

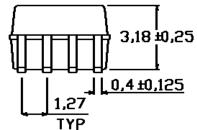
After PN	Description	Packing quantity
None	Surface Mount Tube Packaging	100 pcs per tube
T&R	Surface Mount Tape & Reel	2000 pcs per reel



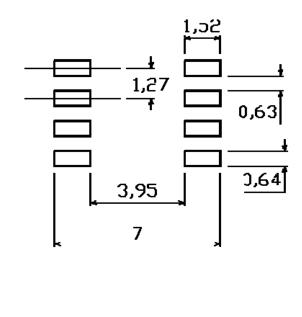
PACKAGE DIMENSIONS (mm)





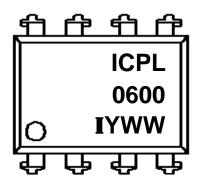


Recommended Solder Pad Layout (mm)



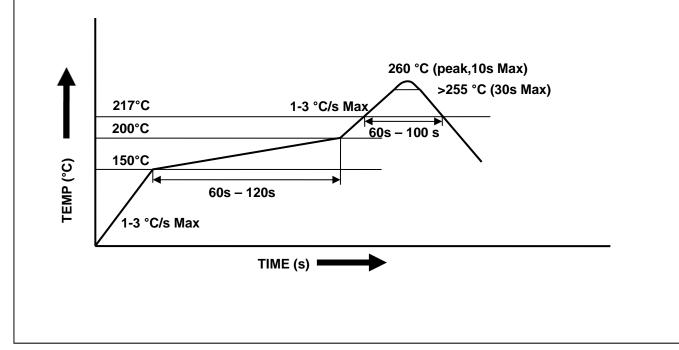


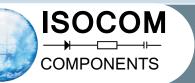
Device Marking (Example ICPL0600)



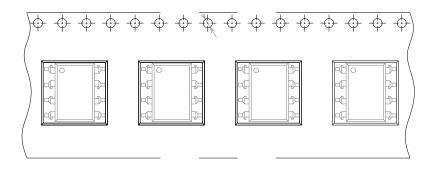
ICPL0600denotes Device Part NumberYdenotes 1 digit Year codeWWdenotes 2 digit Week codeIdenotes Isocom

REFLOW SOLDERING TEMPERATURE PROFILE



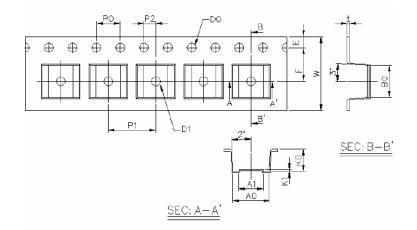


Tape and Reel Packaging



Direction of feed from reel

Г



Dimension No.	A0	A1	В0	D0	D1	Е	F
Dimension (mm)	6.2±0.1	4.1±0.1	5.28±0.1	1.5±0.1	1.5±0.3	1.75±0.1	5.5±0.1
Dimension No.	Ро	P1	P2	t	W	K0	K1

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